



NTE2986
Logic Level MOSFET
N-Channel, Enhancement Mode
High Speed Switch

Features:

- Dynamic dv/dt Rating
- Logic Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4V$ & $5V$
- $+175^{\circ}C$ Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

Absolute Maximum Ratings:

Drain Current, I_D	
Continuous ($V_{GS} = 5V$)	
$T_C = +25^{\circ}C$ 50A
$T_C = +100^{\circ}C$ 36A
Pulsed (Note 1) 200A
Total Power Dissipation ($T_C = +25^{\circ}C$), P_D 150W
Derate Above $25^{\circ}C$ $1.0W/^{\circ}C$
Gate-Source Voltage, V_{GS} $\pm 10V$
Single Pulsed Avalanche Energy (Note 2), E_{AS} 110mJ
Peak Diode Recovery dv/dt (Note 3), dv/dt 4.5V/ns
Operating Junction Temperature Range, T_J -55° to $+175^{\circ}C$
Storage Temperature Range, T_{stg} -55° to $+175^{\circ}C$
Maximum Lead Temperature (During Soldering, 1.6mm from case, 10sec), T_L $+300^{\circ}C$
Mounting Torque, 6-32 or M3 Screw 10 lbf•in (1.1 N•m)
Thermal Resistance:	
Maximum Junction-to-Case, R_{thJC} 1.0K/W
Typical Case-to-Sink (Mounting surface flat, smooth, and greased), R_{thCS} 0.5K/W
Maximum Junction-to-Ambient (Free Air Operation), R_{thJA} 62K/W

Note 1. Repetitive Rating: Pulse width limited by maximum junction temperature.

Note 2. $L = 179\mu H$, $V_{DD} = 25V$, $R_G = 25\Omega$, $I_{AS} = 51A$, Starting $T_J = +175^{\circ}C$.

Note 3. $I_{SD} \leq 51A$, $di/dt \leq 250A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq +175^{\circ}C$.

